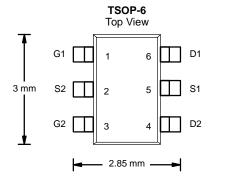
AO6801

Dual P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)			
- 20	0.075 at V_{GS} = - 4.5V	- 4.0	2.7 nC			
- 20	0.100 at V _{GS} = - 2.5 V	- 3.2	2.7 110			

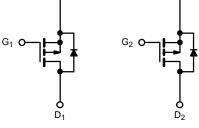


FEATURES

- Halogen-free According to IEC 61249-2-21 ٠ Definition
- TrenchFET[®] Power MOSFET ٠
- 100 % R_g Tested ٠
- Compliant to RoHS Directive 2002/95/EC ٠

APPLICATIONS

- Load Switch for Portable Applications
- Battery Switch for Portable Devices •
- Computers
- Bus Switch
- Load Switch



P-Channel MOSFET

S₁

P-Channel MOSFET

 S_2

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 20	V	
Gate-Source Voltage		V _{GS}	± 12	V	
	T _C = 25 °C		- 4.0		
Continuous Drain Current (T $= 150$ °C)	T _C = 70 °C		- 3.3		
Continuous Drain Current ($T_J = 150 \text{ °C}$)	T _A = 25 °C	I _D	- 3.6 ^{b, c}		
	T _A = 70 °C		-3.1 ^{b, c}	A	
Pulsed Drain Current		I _{DM} - 12			
	T _C = 25 °C		- 1.17		
Continuous Source-Drain Diode Current	T _A = 25 °C	Is	- 0.95 ^{b, c}		
	T _C = 25 °C		1.4		
Maximum Dawar Disainction	T _C = 70 °C		0.9	10/	
Maximum Power Dissipation	T _A = 25 °C	P _D	1.14 ^{b, c}	W	
	T _A = 70 °C		0.73 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, d}	$t \le 5 s$	R _{thJA}	93	110	°C/W		
Maximum Junction-to-Foot	Steady State	R _{thJF}	75	90			

Notes:



RoHS

COMPLIANT

HALOGEN

FREE



Bsemi

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a. T_C = 25 °C.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under steady state conditions is 150 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static					1	1
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 20			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 250		- 17		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μΑ		3.5		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$	- 0.5		- 2.0	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 12 V$			± 100	nA
	I _{DSS}	$V_{DS} = -20 V, V_{GS} = 0 V$			1	μA
Zero Gate Voltage Drain Current		$V_{DS} = -20 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			10	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le$ - 5 V, V_{GS} = - 4.5V	- 8			А
		V _{GS} = - 4.5V, I _D = - 2.5 A		0.075		Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 2.5 V, I _D = - 1 A		0.100		
Forward Transconductance ^a	g_{fs} $V_{DS} = -10 \text{ V}, I_D = -2.6 \text{ A}$			5		S
Dynamic ^b	<u> </u>				I	1
Input Capacitance	C _{iss}			210		
Output Capacitance	C _{oss}	V _{DS} = - 10 V, V _{GS} = 0 V, f = 1 MHz		45		pF
Reverse Transfer Capacitance	C _{rss}			33		
Total Gate Charge	Qg	V_{DS} = - 10 V, V_{GS} = - 4.5 V, I_{D} = - 2.6 A		5.2	8	nC
				2.7	4	
Gate-Source Charge	Q _{gs}	V_{DS} = - 10 V, V_{GS} = - 4.5 V, I_{D} = - 2.6 A		0.94		
Gate-Drain Charge	Q _{gd}			1.3		
Gate Resistance	Rg	f = 1 MHz	2	7	14	Ω
Turn-On Delay Time	t _{d(on)}			39	59	- ns
Rise Time	t _r	V_{DD} = - 10 V, R_L = 7.1 Ω		25	38	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 2.1 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		13	20	
Fall Time	t _f			9	18	
Turn-On Delay Time	t _{d(on)}			5	10	
Rise Time	t _r	V_{DD} = - 10 V, R_L = 7.1 Ω		10	20	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ - 2.1 A, V_GEN = - 4.5 V, $\text{R}_\text{g}\text{=}$ 1 Ω		14	21	
Fall Time	t _f			7	14	
Drain-Source Body Diode Characteristi	cs					
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			1.17	٨
Pulse Diode Forward Current	I _{SM}				8	A
Body Diode Voltage	V _{SD}	I _S = - 2.1 A, V _{GS} = 0 V		0.85	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			13	20	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 2.1 A, dl/dt = 100 A/μs, T _{.1} = 25 °C		6	12	nC
Reverse Recovery Fall Time	ta	$r_F = -2.1 \text{ A}, \text{ al/al} = 100 \text{ A/}\mu\text{s}, \text{I}_J = 25 \text{ °C}$		9		
Reverse Recovery Rise Time	t _b			4		ns

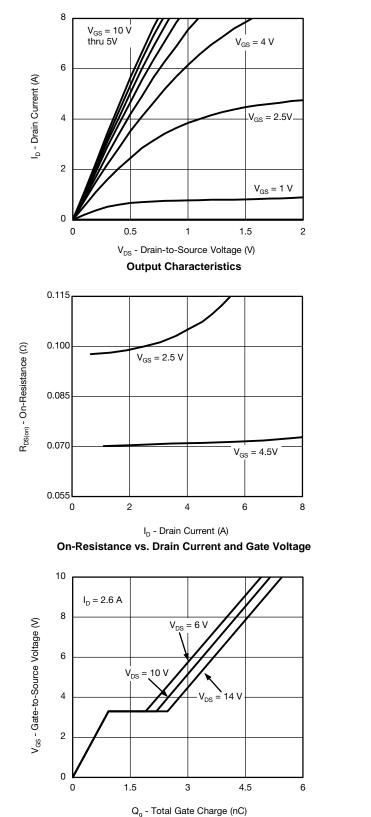
Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %

b. Guaranteed by design, not subject to production testing.

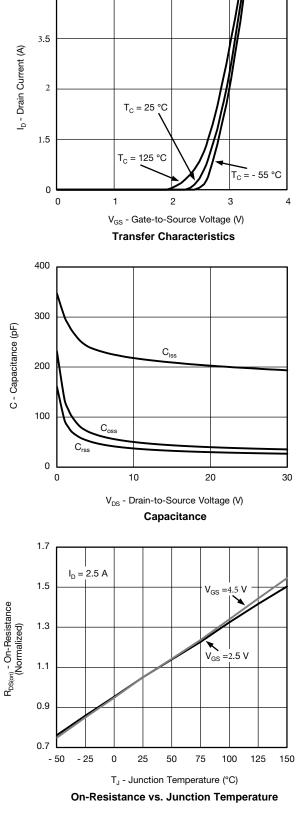
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





Gate Charge

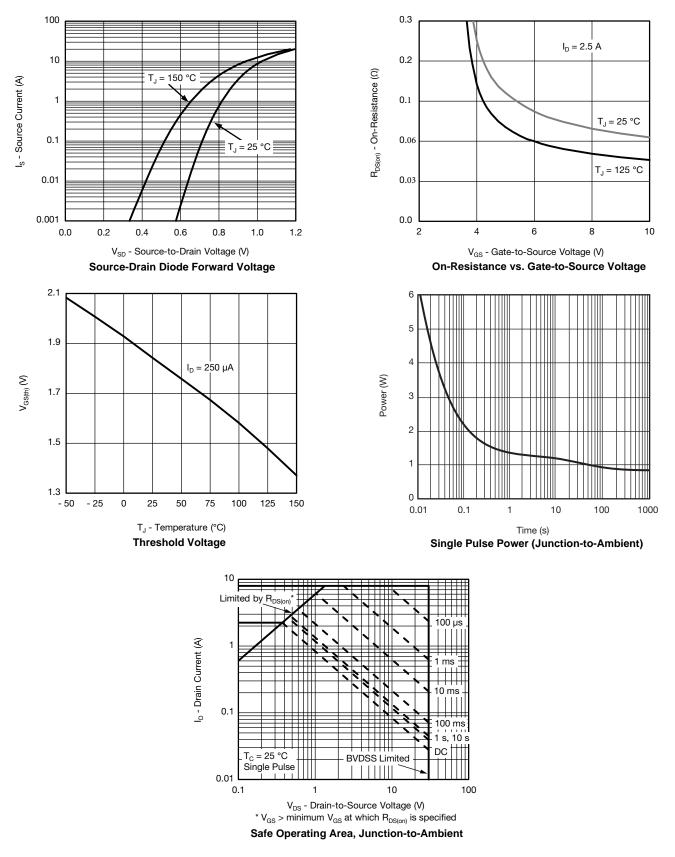
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



4

服务热线:400-655-8788

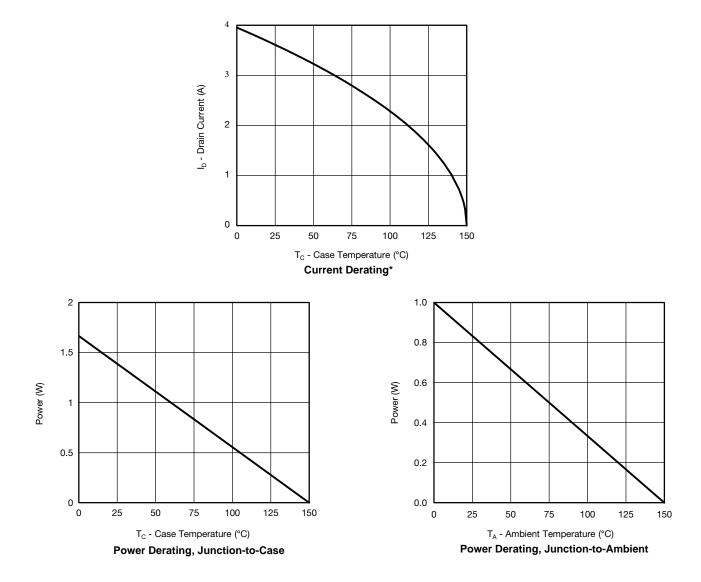




TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

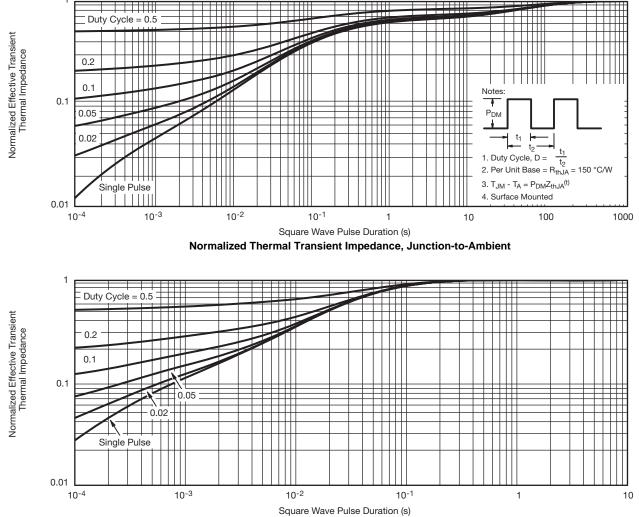


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

1



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

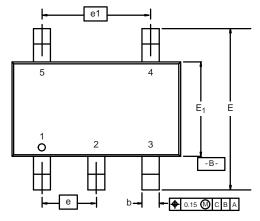
Normalized Thermal Transient Impedance, Junction-to-Foot

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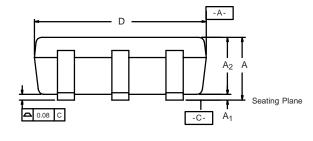
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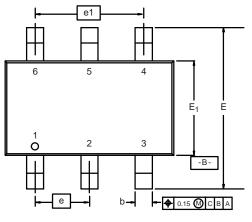


TSOP: 5/6–LEAD JEDEC Part Number: MO-193C

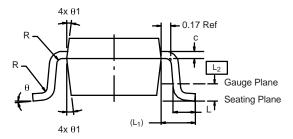








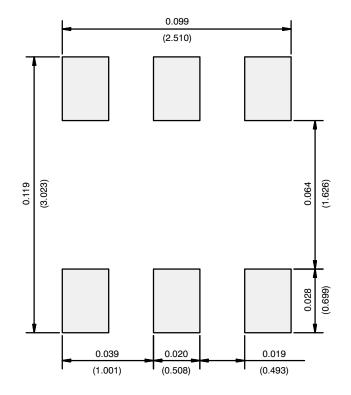
6-LEAD TSOP



	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.91	-	1.10	0.036	-	0.043	
A ₁	0.01	-	0.10	0.0004	-	0.004	
A ₂	0.90	-	1.00	0.035	0.038	0.039	
b	0.30	0.32	0.45	0.012	0.013	0.018	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	2.70	2.85	2.98	0.106	0.112	0.117	
E ₁	1.55	1.65	1.70	0.061	0.065	0.067	
е		0.95 BSC		0.0374 BSC			
e ₁	1.80	1.90	2.00	0.071	0.075	0.079	
L	0.32	-	0.50	0.012	-	0.020	
L ₁		0.60 Ref		0.024 Ref			
L ₂	0.25 BSC			0.010 BSC			
R	0.10	-	-	0.004	-	-	
θ	0°	4°	8°	0°	4°	8°	
θ_1	7° Nom			7° Nom			
ECN: C-06593-Rev. I, 18-Dec-06 DWG: 5540							



RECOMMENDED MINIMUM PADS FOR TSOP-6



Recommended Minimum Pads Dimensions in Inches/(mm)



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